Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	ər
10/037,031	STAMATELAKIS ET AL.	
Examiner	Art Unit	
Steven HD Nguyen	2665	

Steven HD Nguyen

	SEARCHED		
Class	Subclass	Date	Examiner
370	216-228	1/30/2006	ST
714	4, 712	1/30/2006	ST
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